Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/567,815	HAN ET AL.	
Examiner	Art Unit	-
Scott D. Long	1633	

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PALM inventor search: HAN, JAE LIM, JEONG MOOK LEE, YOUNG KIM, JIN NAM HONG, YEONG HAN, BEO	1/21/2008	SL	
EAST search: see attached sheets	1/21/2008	SL	
STN search: see attached sheets	1/21/2008	SL	